

171005146 Updated Errata for Happy Gecko Products

PCN Issue Date: 10/5/2017 Effective Date: 1/11/2018

PCN Type: Other

Description of Change

Silicon Labs is announcing updated errata for EFM32HGXXX and EZR32HGXXX product families. EFM32HGXXX and EZR32HGXXX Errata documents have been updated to v1.30. Both documents modified EMU_110 and added BOOT_E102. The EZR32HG Errata also added BOOT_E103. See Errata for complete details at silabs.com.

Reason for Change

New and updated errata.

Impact on Form, Fit, Function, Quality, Reliability

No impact on form, fit, quality, or reliability. BOOT_E102 affects functionality by adding crystal-less USB support for the version 2.06 production bootloader.

Product Identification

EZR32HG220F32R55G-B0 EZR32HG220F32R55G-B0R EZR32HG220F32R60G-B0 EZR32HG220F32R60G-B0R EZR32HG220F32R61G-B0 EZR32HG220F32R61G-B0R EZR32HG220F32R63G-B0 EZR32HG220F32R63G-B0R EZR32HG220F32R67G-B0 EZR32HG220F32R67G-B0R EZR32HG220F32R68G-B0 EZR32HG220F32R68G-B0R EZR32HG220F32R69G-B0 EZR32HG220F32R69G-B0R EZR32HG220F64R55G-B0 EZR32HG220F64R55G-B0R EZR32HG220F64R60G-B0 EZR32HG220F64R60G-B0R EZR32HG220F64R61G-B0 EZR32HG220F64R61G-B0R EZR32HG220F64R63G-B0 EZR32HG220F64R63G-B0R EZR32HG220F64R67G-B0 EZR32HG220F64R67G-B0R EZR32HG220F64R68G-B0 EZR32HG220F64R68G-B0R EZR32HG220F64R69G-B0 EZR32HG220F64R69G-B0R EZR32HG320F32R55G-B0 EZR32HG320F32R55G-B0R EZR32HG320F32R60G-B0 EZR32HG320F32R60G-B0R EZR32HG320F32R61G-B0 EZR32HG320F32R61G-B0R EZR32HG320F32R63G-B0 EZR32HG320F32R63G-B0R EZR32HG320F32R67G-B0 EZR32HG320F32R67G-B0R EZR32HG320F32R68G-B0 EZR32HG320F32R68G-B0R EZR32HG320F32R69G-B0 EZR32HG320F32R69G-B0R EZR32HG320F64R55G-B0 EZR32HG320F64R55G-B0R EZR32HG320F64R60G-B0 EZR32HG320F64R60G-B0R EZR32HG320F64R61G-B0 EZR32HG320F64R61G-B0R EZR32HG320F64R63G-B0 EZR32HG320F64R63G-B0R EZR32HG320F64R67G-B0 EZR32HG320F64R67G-B0R EZR32HG320F64R68G-B0 EZR32HG320F64R68G-B0R EZR32HG320F64R69G-B0 EZR32HG320F64R69G-B0R EFM32HG108F32G-B-QFN24 EFM32HG108F32G-B-QFN24R

EFM32HG108F64G-B-QFN24	EFM32HG108F64G-B-QFN24R	
EFM32HG110F32G-B-QFN24	EFM32HG110F32G-B-QFN24R	
EFM32HG110F64G-B-QFN24	EFM32HG110F64G-B-QFN24R	
EFM32HG210F32G-B-QFN32	EFM32HG210F32G-B-QFN32R	
EFM32HG210F64G-B-QFN32	EFM32HG210F64G-B-QFN32R	
EFM32HG222F32G-B-QFP48	EFM32HG222F32G-B-QFP48R	
EFM32HG222F64G-B-QFP48	EFM32HG222F64G-B-QFP48R	
EFM32HG308F32G-B-QFN24	EFM32HG308F32G-B-QFN24R	
EFM32HG308F64G-B-QFN24	EFM32HG308F64G-B-QFN24R	
EFM32HG309F32G-B-QFN24	EFM32HG309F32G-B-QFN24R	
EFM32HG309F64G-B-QFN24	EFM32HG309F64G-B-QFN24R	
EFM32HG310F32G-B-QFN32	EFM32HG310F32G-B-QFN32R	
EFM32HG310F64G-B-QFN32	EFM32HG310F64G-B-QFN32R	
EFM32HG321F32G-B-QFP48	EFM32HG321F32G-B-QFP48R	
EFM32HG321F64G-B-QFP48	EFM32HG321F64G-B-QFP48R	
EFM32HG322F32G-B-QFP48	EFM32HG322F32G-B-QFP48R	
EFM32HG322F64G-B-QFP48	EFM32HG322F64G-B-QFP48R	
EFM32HG350F32G-B-CSP36	EFM32HG350F32G-B-CSP36R	
EFM32HG350F64G-B-CSP36	EFM32HG350F64G-B-CSP36R	

Last Date of Unchanged Product: 1/11/2018

Qualification Samples

Samples available upon request.

Specific conditions of acceptance of this change will be considered on a case by case basis if written notice is submitted within 30 days of this notice. To request further data or inquire about this notification, please contact your local Silicon Labs sales representative. A list of Silicon Labs sales representatives is available at http://www.silabs.com.

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Name:	 	
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Email your early Acceptance approval to: PCNEarlyAcceptance@silabs.com

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Qualification Data

See Appendix for qualification data.

EFM32HG* Qualification Report



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Part Rev A1,	TSMC Fabrication, ASEK	R Assembly e	xcept as i	noted			
Test Name	Test Condition	Qualification		Fail/Pass or	Notes	Summary	Status
		-	Start	End	110103	Jannar,	010103
	ccelerated Environment Stress	Tests - CSP - AS	_				
HAST	I		Q37113	0/25	1		
	JA110		Q37378	0/26	1		
	130°C, 85%RH	3 lots, N=>25	Q37419	1/26	1	4 lots	Pass
	Vcc=3.8V, 96 hours		Q37744	0/20	1	1/97	
Temp Cycle	JA104		Q37114	0/27	1		
	Cond C: -65°C to 150°C	3 lots, N=>25	Q37377	0/26	1	3 lots	Pass
	500 cycles		Q37418	0/27	1	0/80	
HTSL	JA103		Q37111	0/27			
	150°C, 1000hr	3 lots, N=>25	Q37374	0/25		3 lots	Pass
			Q37415	0/27		0/79	
Test Group A - A	ccelerated Environment Stress	Tests - QFP					
HAST	JA110		Q37011	0/30	2		
	130°C, 85%RH	3 lots, N=>25	Q37006	0/30	2	3 lots	Pass
	Vcc=3.8V, 96 hours		Q36990	0/30	2	0/90	
uHAST	JA118		Q37014	0/30	2		
	130°C, 85%RH	3 lots, N=>25	Q37009	0/30	2	3 lots	Pass
	96 hours		Q37005	0/30	2	0/90	
Temp Cycle	JA104		Q37013	0/30	2		
	Cond C: -65°C to 150°C	3 lots, N=>25	Q37008	0/30	2	3 lots	Pass
	500 cycles		Q37000	0/30	2	0/90	
HTSL	JA103		Q37012	0/30	2		
	150°C, 1000hr	3 lots, N=>25	Q37007	0/30	2	3 lots	Pass
			Q36999	0/30	2	0/90	
Test Group A - A	ccelerated Environment Stress	Tests - QFN					
HAST	JA110		Q37246	0/30	2		
	130°C, 85%RH	3 lots, N=>25	Q37242	0/30	2	3 lots	Pass
	Vcc=3.8V, 96 hours		Q36986	0/30	2	0/90	
uHAST	JA118		Q37247	0/30	2		
	130°C, 85%RH	3 lots, N=>25	Q37243	0/30	2	3 lots	Pass
	96 hours		Q36987	0/30	2	0/90	
Temp Cycle	JA104		Q37248	0/30	2		
	Cond C: -65°C to 150°C	3 lots, N=>25	Q37244	0/30	2	3 lots	Pass
	500 cycles		Q36988	0/30	2	0/90	
HTSL	JA103		Q36989	0/30	2		
	150°C, 1000hr	3 lots, N=>25	Q37245	0/30	2	3 lots	Pass
	1	,	Q37249	0/30	2	0/90	

EFM32HG* Qualification Report



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Part Rev A1,	TSMC Fabrication, ASE	(R Assembly ex	cept as n	oted			
Test Group B - A	Accelerated Lifetime Simulation	on Tests					
HTOL	JA108		Q36985	0/80			
	125°C, Dynamic	3 lots, N=>77	Q34509	0/80		3 lots	Pass
	Vcc=3.8V, 1000 hours		Q35572	0/80		0/240	
LTOL	JA108						
	-10°C, Dynamic	1 lot, N=>32	Q34510	0/40		1 lots	Pass
	Vcc=3.8V, 1000 hours					0/40	
ELFR	JA108		Q36939	0/508			
	125°C, Dynamic	3 lots, N=>500	Q34886	0/520		3 lots	Pass
	Vcc=3.8V, 48 hours		Q34894	0/503		0/1531	
NVM HTDR	JESD22-A117		Q34896	0/39			
	150°C, 1000 hours	3 lots, N=>39	Q34888	0/40		3 lots	Pass
			Q34513	0/39		0/118	
NVM LTDR	JESD22-A117		Q34895	0/40			
	25°C, 500 hours	3 lots, N=>38	Q34887	0/40		3 lots	Pass
			Q34514	0/39		0/119	
Test Group E - E	lectrical Verification						
ESD-HBM	JA114	1 lot, N=>3	Q37025				±2500 V
ESD-CDM	JC101		Q37115		3		±500 V
	1	1 lot, N=>3	Q36943		4		±1500 V
	1		Q36934		5		±1500 V
			Q37105		6		±1500 V
Latch Up	JESD78	1 lot, N=>3	037022	85 °C			±150mA
	Overvoltage = 3,8V	,	Q37020	25 °C			±200mA

Notes:

- 1. Parts are Pre-conditioned at MSL1/260°C
- 2. Parts are Pre-conditioned at MSL3/260°C
- 3. WLCSP Package
- 4. 7x7 48 QFN
- 5. 6x6 32 QFN
- 6. 5x5 24 QFN

	This report applies to the following part num	bers:
EFM32HG108F32G-B-QFN24	EFM32HG222F64G-B-QFP48	EFM32HG321F32G-B-QFP48
EFM32HG108F64G-B-QFN24	EFM32HG308F32G-B-QFN24	EFM32HG321F64G-B-QFP48
EFM32HG110F32G-B-QFN24	EFM32HG308F64G-B-QFN24	EFM32HG322F32G-B-QFP48
EFM32HG110F64G-B-QFN24	EFM32HG309F32G-B-QFN24	EFM32HG322F64G-B-QFP48
EFM32HG210F32G-B-QFN32	EFM32HG309F64G-B-QFN24	EFM32HG350F32G-B-CSP36
EFM32HG210F64G-B-QFN32	EFM32HG310F32G-B-QFN32	EFM32HG350F64G-B-CSP36
EFM32HG222F32G-B-QFP48	EFM32HG310F64G-B-QFN32	

Approved by: Kathy Torres

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EZR32HG Qualification Report

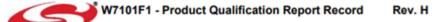
W7101F1 - Product Qualification Report Record Rev. I

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Part Rev B0,	art Rev B0, TSMC Fabrication, ASECL Assembly except as noted						
				Fail/Pass or			01-1
Test Name		Qualification	Start	End	Notes	Summary	Status
	ccelerated Environment Stress T	ests					
HAST	JA110		Q038335	0/28	1		
	130°C, 85%RH 3	lots, N=>25	Q038554	1/30	1		
	Vcc=5.5V, 96 hours		Q038847	0/40	1	4 lots	Pass
			Q038585	0/30	1	1/128	
Temp Cycle	JA104		Q038337	0/33	1		
	Cond C: -65°C to 150°C 3	lots, N=>25	Q038556	0/30	1	3 lots	Pass
	500 cycles		Q038587	0/30	1	0/93	
HTSL	JA103		Q038336	0/32	1		
	150°C, 1000hr 3	lots, N=>25	Q038555	0/30	1	3 lots	Pass
			Q038586	0/30	1	0/92	
Test Group B – A	ccelerated Lifetime Simulation T	ests					
HTOL	JA108		Q034509	0/80	2		
l	T _J ≥ 125°C, Dynamic 3	lots, N=>77	Q035572	0/80	2		
l	Vcc=5.5V, 1000 hours		Q036985	0/80	2		
l			Q035137	0/85	3, 4		
l			Q035721	0/81	3, 4	6 lots	Pass
			Q035945	0/83	3, 4	0/489	
LTOL	JA108		Q034510	0/40	2		
l	T _A = -10°C, Dynamic 1	lot, N=>32	Q030413	0/80	3, 4	2 lots	Pass
l	Vcc=5.5V, 1000 hours					0/120	
ELFR	JA108		Q036939	0/508	2		
l	T _J ≥ 125°C, Dynamic 3	lots, N=>500	Q037580	0/509	2		
l	Vcc=5.5V, 48 hours		Q038094	0/511	2		
l			Q035671	0/818	3, 4		
l			Q035612	0/814	3, 4	6 lots	Pass
l			Q035944	0/812	3, 4	0/3972	. 000
Test Group E - E	lectrical Verification						
ESD-HBM	JDS-001		Q038096		2		Class 2
		lot, N=>3	Q035921		3		Class 2
I		101,11-70	SCOOOL I				U1033 E
ESD-CDM	JC101					 	
		lot, N=>3	Q038467				Class II
		101, 14-23	2030407				Class II
Latch Up	JESD78		Q038097	85 °C	2	 	
	±100mA 1	lot, N=>3	Q035946	125 °C	3, 5		Pass
	Overvoltage = 8.25V						

Approved by: J. Engel 1 of 2 Prepared on: 31-May-2016

EZR32HG Qualification Report



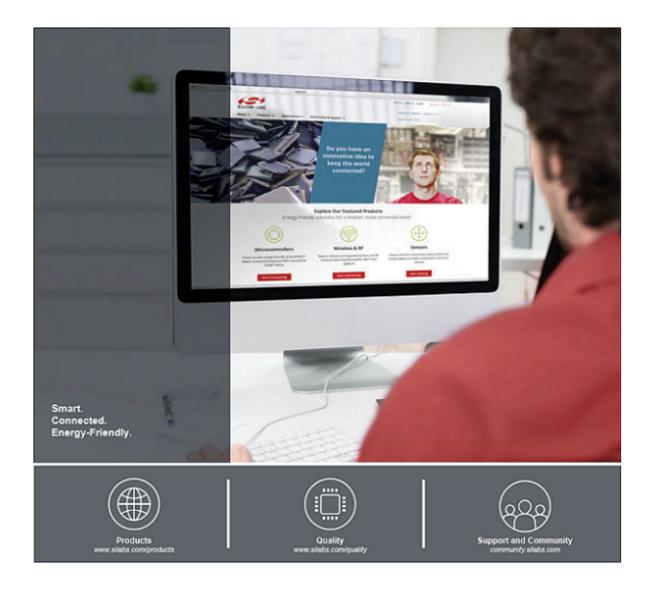
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Part Rev B0, TSMC Fabrication, ASECL Assembly except as noted							
			Lot ID or	Fail/Pass or			
Test Name	Test Condition	Qualification	Start	End	Notes	Summary	Status

Notes:

- 1. Parts are Pre-conditioned at MSL3/260°C
- 2. Performed on MCU die
- 3. Performed on RF die
- 4. Vcc = 3.6V
- 5. Over-voltage applied 5.7V

This report applies to the	following part numbers:
EZR32HG220F32R55G-B0	EZR32HG320F32R55G-B0
EZR32HG220F32R60G-B0	EZR32HG320F32R60G-B0
EZR32HG220F32R61G-B0	EZR32HG320F32R61G-B0
EZR32HG220F32R63G-B0	EZR32HG320F32R63G-B0
EZR32HG220F32R67G-B0	EZR32HG320F32R67G-B0
EZR32HG220F32R68G-B0	EZR32HG320F32R68G-B0
EZR32HG220F32R69G-B0	EZR32HG320F32R69G-B0
EZR32HG220F64R55G-B0	EZR32HG320F64R55G-B0
EZR32HG220F64R60G-B0	EZR32HG320F64R60G-B0
EZR32HG220F64R61G-B0	EZR32HG320F64R61G-B0
EZR32HG220F64R63G-B0	EZR32HG320F64R63G-B0
EZR32HG220F64R67G-B0	EZR32HG320F64R67G-B0
EZR32HG220F64R68G-B0	EZR32HG320F64R68G-B0
EZR32HG220F64R69G-B0	EZR32HG320F64R69G-B0
EZR32HG220F64R61SFG-B0	EZR32HG220F64R68SFG-B0



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